Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/521,622	HAGIO ET AL.
Examiner	Art Unit

Susan E. Fernandez

1651

SEARCHED				
Class	Subclass	Date	Examiner	
435	468,470, 173.1, 173.6,410	9/28/2007	SEF	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: US-PGPUB, USPAT, EPO, JPO, DERWENTsee search history	9/28/2007	SEF		
STN: CAPLUS, BIOSISsee search history	9/28/2007	SEF		
inventor name search: PALM and STN	9/28/2007	SEF		
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